Please type a plus sign (+) inside this box —			
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Substitute for form 1449A/B/PTO	Application Number	10/574,785	
INFORMATION DISCLOSURE	Filing Date	March 8, 2007	
OTATEMENT DV ADDI IOANT	First Named Inventor	Takashi Nakagawa	

STATEMENT BY APPLICANT

(Use as many sheets as necessary) Sheet

Complete if Known			
Application Number	10/574,785		
Filing Date	March 8, 2007		
First Named Inventor	Takashi Nakagawa		
Group Art Unit	2123		
Examiner Name	Unassigned		
Attorney Docket Number	403683		

			U.S	S. PATENT DOCUMENTS		
		U.S. Patent Docur	ment			
Examiner Initials	Doc. No.	Application or Patent Number	Kind Code	Name of Patentee or Applicant	Date of Publication	Filing Date If Appropriate
						

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		Foreign Patent Document					
Examiner Initials	Doc. No.	Office	Application or Patent Number	Kind Code	Name of Patentee or Applicant	Date of Publication	Translation *
	C 1	JP	4-51367	Α	Toshiba Corp	02/19/1992	X*
	C 2	JP	11-45176	A	Toshiba Corp	02/16/1999	X*
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		OTHER - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials Doc. No.		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number (s), publisher, city and/or country where published.			
	C 3	Fang et al., "Analysis Approach for Software Reconstruction", Technology Research Report, Information Processing Society of Japan, Vol. 2000, No. 46, pp 23-30 (May 2000)			
	C 4	Takura et al., "Requirements for Acquisition for Communication Service Specification", Technology Research Report, EICE, Vol. 93, No. 160, pp 61-67 (July 1993)			

Examiner Signature	Date Considered	

^{*} If the reference is not in English, then at least one of the following is provided: (a) an English translation in whole or in part or (b) a concise statement of relevance in the form of, for example, an English language counterpart, an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office.